Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,806	LAI ET AL.	
Examiner	Art Unit	•

2181

David E. Martinez

SEARCHED				
				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
710	52,53	6/21/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		6/21/2006	DM

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East see attached	6/21/2006	DM
Inventor Search eDan	6/21/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	6/21/2006	DM
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